

of Kremny's antidumping duty margin using the revised antidumping duty margin for Bratsk calculated in the *First Remand Results*. Consistent with the decision of the United States Court of Appeals for the Federal Circuit ("Federal Circuit") in *Timken Co. v. United States*, 893 F.2d 337 (Fed. Cir. 1990) ("Timken"), the Department is notifying the public that the *Globe Metallurgical III* decision is "not in harmony" with the Department's final determination.

FOR FURTHER INFORMATION CONTACT:

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SUPPLEMENTARY INFORMATION:

Background

On February 11, 2003, the Department published its *Amended Final Determination*, covering the period of investigation ("POI") from July 1, 2001, through December 31, 2001. See *Notice of Final Determination of Sales at Less Than Fair Value: Silicon Metal From the Russian Federation*, 68 FR 6885 (February 11, 2003) ("*Final Determination*"), as amended by *Notice of Amended Final Determination of Sales at Less Than Fair Value: Silicon Metal From the Russian Federation*, 68 FR 12037 (March 13, 2003) ("*Amended Final Determination*"). Petitioners and Bratsk contested various aspects of the *Amended Final Determination*.

The Court remanded to the Department two aspects of its *Amended Final Determination* for reconsideration: (1) with respect to the Department's decision not to use Russian values to value the factors of production and other expenses, the Court ordered the Department to either use Russian post-non-market economy ("NME") values or explain why the market economy Russian values are not the best available information; and (2) with respect to the Department's treatment of silicon metal fines, the Court granted the Department's request to explain its exclusion of recycled silicon metal fines from the factor of production cost analysis. See *Globe Metallurgical, Inc. v. United States*, 350 F.Supp. 2d 1148 (CIT September 24, 2004) ("*Globe Metallurgical I*"). Subsequent to the Court's remand, Bratsk voluntarily dismissed its challenge of the Department's rejection of Russian post-NME values. Therefore this issue became moot.

In the Department's *First Remand Results*, the Department recalculated

Bratsk's and Kremny's margins to value the usage of recycled silicon metal sized zero to five millimeters.

On July 27, 2005, the CIT issued its opinion on the Department's *First Remand Results*. See *Globe Metallurgical, Inc. v. United States*, Slip Op. 05-90 (CIT July 27, 2005) ("*Globe Metallurgical II*"). The CIT affirmed the Department's determination to include recycled silicon metal fines sized zero to five millimeters in each producer's factors of production cost analysis and affirmed the calculation of Bratsk's antidumping duty margin. However, the Court further remanded the case back to the Department and ordered the Department to either recalculate the AFA portion of Kremny's antidumping duty margin using the revised antidumping duty margin for Bratsk calculated in the *Final Remand Results* or explain the use of the Bratsk margin from the *Amended Final Determination*. The Department recalculated Kremny's antidumping duty margin using the antidumping duty margin for Bratsk calculated in the *First Remand Results*. On October 25, 2005, the Department filed its *Second Remand Results*. On November 28, 2005, the CIT sustained the Department's *Second Remand Results* in all respects. See *Globe Metallurgical III*.

Timken Notice

In its decision in Timken, the Federal Circuit held that, pursuant to 19 U.S.C. 1516a(e), the Department must publish notice of a decision of the CIT which is "not in harmony" with the Department's results. The CIT's decision in *Globe Metallurgical III* was not in harmony with the Department's final determination. Therefore, publication of this notice fulfills the obligation. The Department will issue revised cash deposit instructions effective the date of publication of this notice in the **Federal Register** if the CIT's decision is not appealed, or if it is affirmed on appeal.

Dated: December 7, 2005.

Joseph A. Spetrini,

Acting Assistant Secretary for Import Administration.

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DEPARTMENT OF COMMERCE

International Trade Administration

**Georgia Institute of Technology, et al.
Notice of Consolidated Decision on
Applications for Duty-Free Entry of
Electron Microscopes**

This is a decision consolidated pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, Franklin Court Building, U.S. Department of Commerce, 1099 14th Street, NW., Washington, DC.

Docket Number: 05-041. *Applicant:* Georgia Institute of Technology, Atlanta, GA 30332. *Instrument:* Dual Beam Electron Microscope, Model Quanta 200 3D Nanolab. *Manufacturer:* FEI Company, Czech Republic. *Intended Use:* See notice at 70 FR 67450, November 7, 2005. *Order Date:* April 4, 2004.

Docket Number: 05-042. *Applicant:* Georgia Institute of Technology, Atlanta, GA 30332. *Instrument:* Electron Microscope, Model NOVA 200 3D Nanolab. *Manufacturer:* FEI Company, Czech Republic. *Intended Use:* See notice at 70 FR 67451, November 7, 2005. *Order Date:* April 4, 2004.

Docket Number: 05-043. *Applicant:* Massachusetts General Hospital, Boston, MA 02114. *Instrument:* Electron Microscope, Model JEM-1011. *Manufacturer:* JEOL, Ltd., Japan. *Intended Use:* See notice at 70 FR 67451. *Order Date:* January 13, 2005.

Comments: None received. *Decision:* Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as these instruments are intended to be used, was being manufactured in the United States at the time the instruments were ordered. *Reasons:* Each foreign instrument is an electron microscope and is intended for research or scientific educational uses requiring an electron microscope. We know of no electron microscope, or any other instrument suited to these purposes, which was being manufactured in the United States either at the time of order of each instrument OR at the time of receipt of application by U.S. Customs and Border Protection.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

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